

### SEMITRANS<sup>®</sup> 2

### V Series IGBT Module

### SKM200GAL12VL2

#### Features\*

- V-IGBT = 6. Generation Trench V-IGBT (Fuji)
- CAL4 = Soft switching 4. Generation CAL-diode
- Insulated copper baseplate using DBC technology (Direct Bonded Copper)
- Increased power cycling capability
- With integrated gate resistor
- UL recognized, file no. E63532
- Lowest switching losses at High di/dt

### **Typical Applications**

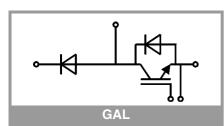
- Electronic welders
- DC/DC converter
- Brake chopper
- Switched reluctance motor

#### Remarks

- Case temperature limited to T<sub>c</sub> = 125°C max.
- Recommended  $T_{op} = -40 \dots +150^{\circ}C$
- Product reliability results valid for T<sub>j</sub> = 150°C

Symbol	Conditions		Values	Unit	
IGBT					
V <sub>CES</sub>	T <sub>j</sub> = 25 °C		1200	V	
lc	T 175 %	T <sub>c</sub> = 25 °C	299	А	
	– T <sub>j</sub> = 175 °C	T <sub>c</sub> = 80 °C	228	А	
I <sub>Cnom</sub>			200	А	
I <sub>CRM</sub>			600	А	
V <sub>GES</sub>			-20 20	V	
t <sub>psc</sub>	$V_{CC} = 720 V$ $V_{GE} \le 15 V$ $V_{CES} \le 1200 V$	T <sub>j</sub> = 125 °C	10	μs	
Tj			-40 175	°C	
Inverse d	iode				
V <sub>RRM</sub>	T <sub>j</sub> = 25 °C		1200	V	
I <sub>F</sub>	T <sub>j</sub> = 175 °C	T <sub>c</sub> = 25 °C	189	Α	
		T <sub>c</sub> = 80 °C	141	A	
I <sub>FRM</sub>			450	А	
I <sub>FSM</sub>	$t_p = 10 \text{ ms}, \sin 180^\circ, T_j = 25 ^\circ\text{C}$		900		
Tj			-40 175		
Freewhee	eling diode	·			
V <sub>RRM</sub>	T <sub>j</sub> = 25 °C		1200	V	
l <sub>F</sub>	T <sub>j</sub> = 175 °C	T <sub>c</sub> = 25 °C	229	Α	
		T <sub>c</sub> = 80 °C	172	А	
I <sub>FRM</sub>			600	Α	
I <sub>FSM</sub>	t <sub>p</sub> = 10 ms, sin 180°, T <sub>j</sub> = 25 °C		990		
Tj			-40 175	°C	
Module					
I <sub>t(RMS)</sub>			200	Α	
T <sub>stg</sub>	module without TIM		-40 125	°C	
V <sub>isol</sub>	AC sinus 50 Hz, t = 1 min		4000	V	

Characte	ristics					
Symbol	Conditions	min.	typ.	max.	Unit	
IGBT						
$V_{GE} = 15$	I <sub>C</sub> = 200 A	T <sub>j</sub> = 25 °C		1.86	2.30	V
	V <sub>GE</sub> = 15 V chiplevel	T <sub>j</sub> = 150 °C		2.20	2.66	V
V <sub>CE0</sub>	chiplevel	T <sub>j</sub> = 25 °C		0.94	1.07	V
		T <sub>j</sub> = 150 °C		0.88	0.98	V
r <sub>CE</sub>	V <sub>GE</sub> = 15 V chiplevel	T <sub>j</sub> = 25 °C		4.6	6.2	mΩ
		T <sub>j</sub> = 150 °C		6.6	8.4	mΩ
V <sub>GE(th)</sub>	$V_{GE}=V_{CE}$ , $I_{C}=8$ mA		5.5	6	6.5	V
I <sub>CES</sub>	$V_{GE} = 0 V, V_{CE} = 1200 V, T_j = 25 °C$				0.3	mA
Cies	V <sub>CE</sub> = 25 V V <sub>GE</sub> = 0 V	f = 1 MHz		12.0		nF
C <sub>oes</sub>		f = 1 MHz		1.18		nF
C <sub>res</sub>		f = 1 MHz		1.18		nF
$Q_{G}$	V <sub>GE</sub> = - 8 V+ 15 V			2210		nC
R <sub>Gint</sub>	T <sub>j</sub> = 25 °C			3.8		Ω





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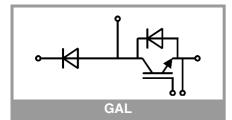
### **Typical Applications**

- · Electronic welders
- DC/DC converter
- Brake chopper
- Switched reluctance motor

#### Remarks

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Characte	eristics					
Symbol	Conditions		min.	typ.	max.	Unit
IGBT						
t <sub>d(on)</sub>	V <sub>CC</sub> = 600 V	T <sub>j</sub> = 150 °C	İ	305		ns
t <sub>r</sub>	$I_{\rm C} = 200  {\rm A}$	T <sub>j</sub> = 150 °C		51		ns
Eon	$V_{GE} = +15/-15 V$ R <sub>G on</sub> = 1 Ω	T <sub>j</sub> = 150 °C		24		mJ
t <sub>d(off)</sub>	$R_{G off} = 1 \Omega$	T <sub>j</sub> = 150 °C		493		ns
t <sub>f</sub>	$di/dt_{on} = 4500 \text{ A}/\mu \text{s}$	T <sub>j</sub> = 150 °C		88		ns
E <sub>off</sub>	di/dt <sub>off</sub> = 2060 A/μs dv/dt = 5400 V/μs	T <sub>j</sub> = 150 °C		22		mJ
R <sub>th(j-c)</sub>	per IGBT				0.14	K/W
R <sub>th(c-s)</sub>		.81 W/(m*K))		0.056		K/W
R <sub>th(c-s)</sub>	per IGBT (λ <sub>grease</sub> =0.81 W/(m*K)) per IGBT, pre-applied phase change material			0.038		K/W
Inverse d	iode		1			
	I <sub>F</sub> = 150 A	T <sub>i</sub> = 25 °C		2.14	2.46	V
1 20	V <sub>GE</sub> = 0 V chiplevel	T <sub>j</sub> = 150 °C		2.04	2.38	V
V <sub>F0</sub>	chiplevel	T <sub>j</sub> = 25 °C		1.30	1.50	V
		T <sub>j</sub> = 150 °C		0.90	1.10	V
r <sub>F</sub>	chiplevel	T <sub>j</sub> = 25 °C		5.6	6.4	mΩ
		T <sub>j</sub> = 150 °C		7.6	8.7	mΩ
I <sub>RRM</sub>		T <sub>j</sub> = 150 °C		92		Α
Q <sub>rr</sub>	$di/dt_{off} = 2250 \text{ A/}\mu\text{s}$	T <sub>j</sub> = 150 °C		25		μC
E <sub>rr</sub>	V <sub>GE</sub> = -15 V V <sub>CC</sub> = 600 V	T <sub>j</sub> = 150 °C		8.5		mJ
R <sub>th(j-c)</sub>	per diode				0.31	K/W
R <sub>th(c-s)</sub>	per diode ( $\lambda_{grease}$ =0.81 W/(m*K))			0.07		K/W
R <sub>th(c-s)</sub>	per diode, pre-applied phase change material			0.063		K/W
Freewhee	ling diode		1			
$V_F = V_{EC}$	I <sub>F</sub> = 200 A	T <sub>j</sub> = 25 °C		2.20	2.52	V
	V <sub>GE</sub> = 0 V chiplevel	T <sub>j</sub> = 150 °C		2.16	2.47	V
V <sub>F0</sub>	chiplevel	T <sub>j</sub> = 25 °C		1.30	1.50	V
	Chiplevel	T <sub>j</sub> = 150 °C		0.90	1.10	V
r <sub>F</sub>	chiplevel	T <sub>j</sub> = 25 °C		4.5	5.1	mΩ
		T <sub>j</sub> = 150 °C		6.3	6.9	mΩ
I <sub>RRM</sub>	$I_{\rm F} = 200  {\rm A}$	T <sub>j</sub> = 150 °C		170		Α
Q <sub>rr</sub>	di/dt <sub>off</sub> = 3950 A/µs V <sub>GE</sub> = -15 V	T <sub>j</sub> = 150 °C		33		μC
E <sub>rr</sub>	$V_{GE} = -15 V$ $V_{CC} = 600 V$	T <sub>j</sub> = 150 °C		13		mJ
R <sub>th(j-c)</sub>	per diode	1			0.26	K/W
R <sub>th(c-s)</sub>	per diode ( $\lambda_{grease}=0$	0.81 W/(m*K))		0.068		K/W
R <sub>th(c-s)</sub>	per diode, pre-appl material			0.061		K/W





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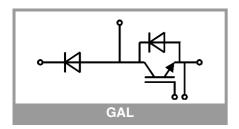
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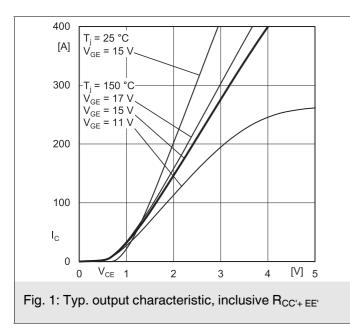
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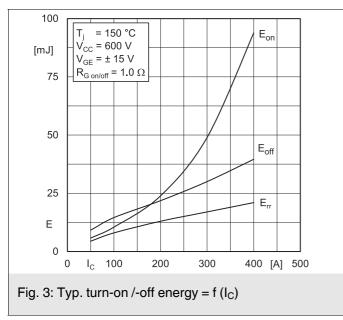
#### Remarks

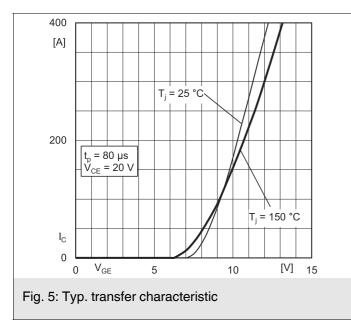
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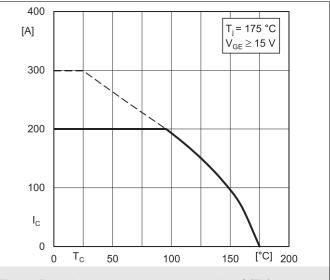
Characte	eristics					
Symbol	Conditions		min.	typ.	max.	Unit
Module						
L <sub>CE</sub>				30		nH
R <sub>CC'+EE'</sub>	measured per	T <sub>C</sub> = 25 °C		0.65		mΩ
	switch	T <sub>C</sub> = 125 °C		1.09		mΩ
R <sub>th(c-s)1</sub>	calculated without thermal coupling $(\lambda_{grease}=0.81 \text{ W}/(\text{m}^{*}\text{K}))$			0.0311		K/W
R <sub>th(c-s)2</sub>	including thermal c T <sub>s</sub> underneath moc $(\lambda_{grease}=0.81 \text{ W/(m})$	lule		0.034		K/W
R <sub>th(c-s)2</sub>	including thermal coupling, $T_s$ underneath module, pre-applied phase change material			0.026		K/W
Ms	to heat sink M6		3		5	Nm
Mt		to terminals M5	2.5		5	Nm
	1					Nm
w		<u>I</u>			160	g

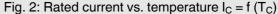


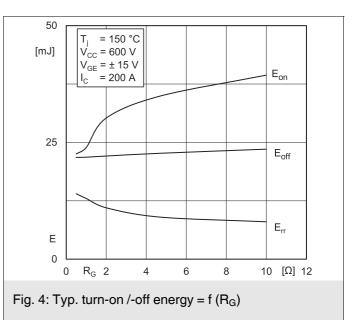


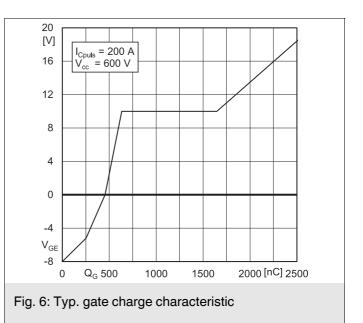


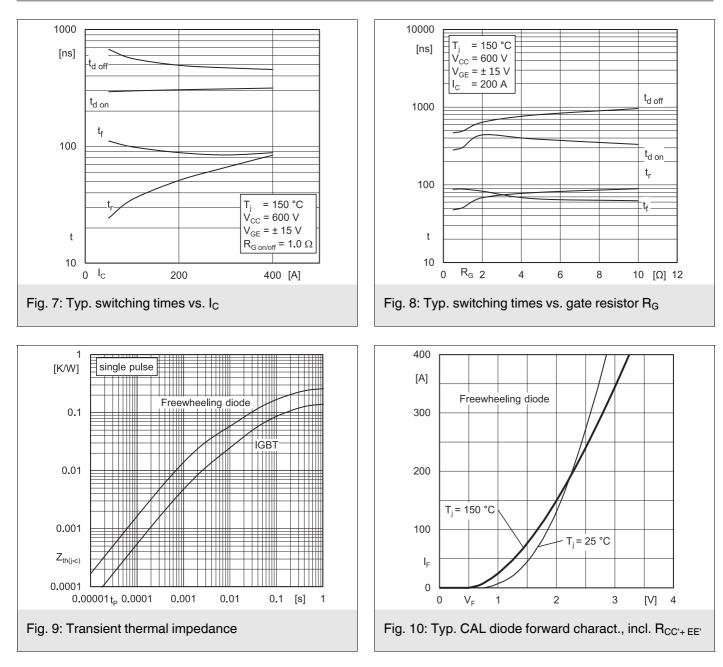




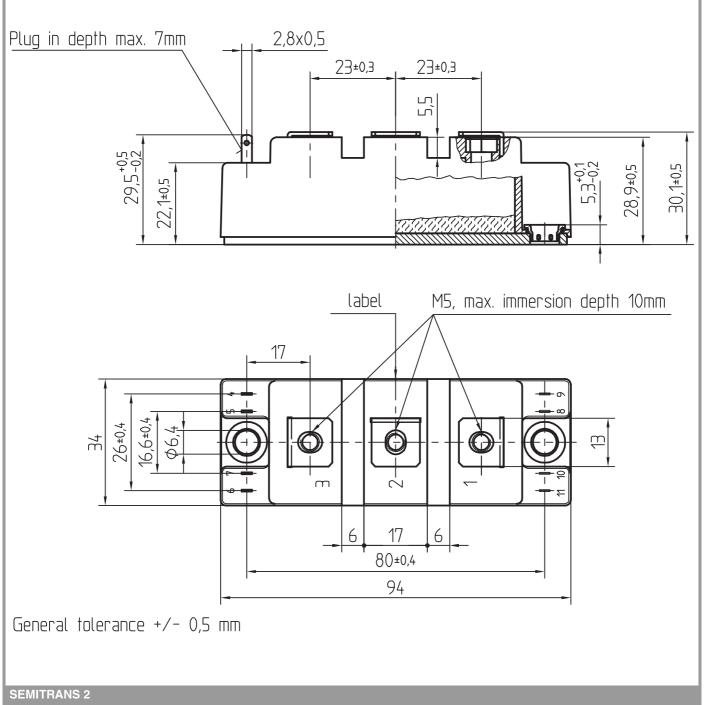


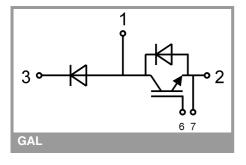






Dimensions in mm





This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, chapter IX.

#### **\*IMPORTANT INFORMATION AND WARNINGS**

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